

## **Coaxial Protector Reliability Analysis**

The purpose of this paper is to estimate the reliability of NexTek coaxial lightning protectors. This analysis is a valuable tool to assist in planning the economics and repair of coaxial protectors. NexTek protectors are exceptionally long lifetime devices, with lifetimes of over 10 million to billions of hours (Equating to a typical annual failure rate of 0.023%/yr to an even less 0.00054%/yr). Without a lightning protection device installed, the risk of equipment damage from lightning ranges from a few percent up to 100% per year. Therefore, adding a high quality NexTek lightning protector will result in negligible additional equipment failure rates when compared to the level of damage that is prevented.



**Typical PTR & PTC Devices** 

The reliability prediction for a NexTek lightning protector is calculated as the sum of a single connector pair (representing the input and output half connectors) and a protection component (required for the Gas-Discharge-Tube



**QSS Devices** 

(GDT) based PTC and PTR series). Note that the QSS/QWS series are quarter wave stub based protectors and therefore do not use such a component. The PTR analysis assumes GDT maintenance sufficient to eliminate 80% of the GDT component failures. If there is no preventative maintenance, use the PTC reliability for PTR models. Also, this analysis is for the NexTek protector only. Due to the extensive military qualification of NexTek products, we use MIL-STD quality factors. Please add the mating connector halves with the appropriate quality factor for the cable connectors mating to the NexTek protector.

The model for the failure rate of a NexTek coaxial protector is given in equation 1:

## $\lambda$ Protector = $\lambda$ Connector + $\lambda$ Suppressor $\pi_{MT}$

(1)

Where  $\lambda$ Protector is the failure rate of the protector,  $\lambda$  Connector is the failure rate for a single connector pair (for the two halves of the NexTek protector,  $\lambda$  Suppressor is the failure rate of a single suppression component, and  $\pi_{MT}$  is the maintenance and technology factor. The value of  $\pi_{MT}$  for is 1.0 for a PTC or a PTR without maintenance, 0.2 for a PTR with maintenance, or 0.0 for a QSS/QWS, since there is no suppression component.

The reliability of NexTek coaxial protectors is summarized in the table 1 below. The failure rate is in failures per 10<sup>6</sup> hours. The mean time between failures (MTBF) is measured in hours. Note that this reliability does not include the significant failure rate reduction of attached equipment or system due to protection, or of the influence of transients on the failure of the protector.

The detailed calculations are provided in the following sections A & B.



Table 1. Predicted Failure Rate and MTBF of NexTek Coaxial Protectors

NEXTEK PROTECTOR MODEL TYPES							
Failure Rate = 1/10 <sup>6</sup> hrs	PTC – fixed GDT		PTR – repla		QSS/QWS – quarter wave stub		
MTBF listed in hours	(or PTR w/o maintenance)		(with preventive	e maintenance)	(all models)		
Environment Reliability Parameters	Failure Rate	MTBF	Failure Rate	MTBF	Failure Rate	MTBF	
Low Mating 50°C and Ground Fixed	0.00844	118,483,794	0.00217999	458,717,280	0.000615	1,626,061,260	
Low Mating 30°C and Ground Mobile	0.0100102	99,897,705	0.00488845	204,563,092	0.003608	277,161,863	
High Mating, 50°C and Ground Mobile	0.0264794	37,739,495	0.01710479	58,453,935	0.01476	67,750,768	
Moderate Mating 50°C and Naval Surface	0.0178874	55,905,419	0.00849749	117,681,873	0.00615	162,601,626	
Moderate Mating, 70°C and Aircraft Inhabited	0.038256	26,140,401	0.01421099	70,368,064	0.0082	121,951,202	

## A. λ Connector

For a general idea of connector reliability, the generic failure rates can be considered. The mated pair Generic Failure Rate  $(\lambda_g)$  is per MIL-HDBK-217F Notice 2, Appendix A, Section 15.1, RF Coaxial. The failure rate for several environments is given in table 2.

Table 2. Generic Failure Rate (/106hours) Coaxial Connectors

Environment	$G_{F}$	$G_{M}$	Ns	A <sub>IC</sub>	
T <sub>A</sub> (°C)	40	45	40	55	
Failure Rate $\lambda_g$	0.00053	0.0046	0.0027	0.002	

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For more detailed predictions, the model provided in Connector Prediction per MIL-HDBK-217F/Notice 2 Section 15.1 is used. For a mated pair of connectors, the failure rate is modeled by equation 2:

$$\lambda_{p} = \lambda_{b} \, \pi_{T} \, \pi_{K} \, \pi_{Q} \, \pi_{E} \tag{2}$$

Where  $\lambda_p$  =is the predicted failure rate in failures per 10<sup>6</sup> hours,  $\lambda_b$  is the base failure rate,  $\pi_T$  is the temperature factor,  $\pi_K$  is the mating rate factor,  $\pi_Q$  is the quality factor, and  $\pi_E$  is the environment factor. The reliability predictions with typical factors are shown table 3:

**Table 3 Predicted Failure Rate of Coaxial Connectors** 

Single Connector		πτ	πκ	πο	πΕ	$\lambda_{p}$	
Law Mating and Madison Target systems and County of Fixed	0.00041	1.5	1	1	1	0.000615	
Low Mating and Medium Temperature and Ground Fixed	Base FR	50°C	<0.05	MIL	$G_{F}$		
Law Mating and Tampayatura and Crawad Mahila	0.00041	1.1	1	1	8	0.003608	
Low Mating and Temperature and Ground Mobile	Base FR	30°C	<0.05	MIL	$G_{M}$		
Library Marking of Markings Taylors and Opening Marking	0.00041	1.5	3	1	8	0.01476	
High Mating, Medium Temp. and Ground Mobile	Base FR	50°C	<50	MIL	$G_{M}$		
Madayata Mating and Tappa and Naval Curface	0.00041	1.5	2	1	5	0.00045	
Moderate Mating and Temp and Naval Surface	Base FR	50°C	<5	MIL	$N_S$	0.00615	
Madayata Mating, High Tayan and Aiyayaft lahahitad	0.00041	2.0	2	1	5	0.0000	
Moderate Mating, High Temp and Aircraft Inhabited	Base FR	70°C	<5	MIL	A <sub>IC</sub>	0.0082	



Note that  $\pi_K$  relates to average times between mating cycles. To illustrate the average mating or cycling time, the cycles per thousand hours has been converted to time between mating in table 4.

**Connection Cycle Rate** Avg. maximum time Cycles / 1000 hr  $\pi_{\mathsf{K}}$ (for Maintenance or Deployment) between mating 0<cycles<0.05 Permanently Installed / Rarely Cycled Over 28+ months 1 Infrequent 1.5 0.05<cycles<0.5 2.8 months 2 0.5<cycles<5 Moderate 9 days Frequent 3 5<cycles<50 20 hours

Table 4  $\pi_K$  and Maximum Average Time between Mating

## B. λ Suppressor

For a general idea of the reliability of the shunting component, the generic failure rates for varistors are considered. The Generic Failure Rate ( $\lambda_g$ ) per MIL-HDBK-217F Notice 2, Appendix A, Section 6.1, Suppressor/Varistor is given below. Note that the junction temperatures relate to power dissipation and cooling functions, whereas the protection component temperature is more closely related to the ambient temperature. The generic failure rates for several environments are shown in table 5.

Table 5 Generic Failure Rate (/10<sup>6</sup>hours) of Suppression Components

Environment	G <sub>F</sub>	G <sub>M</sub>	Ns	A <sub>IC</sub>	
T <sub>J</sub> (°C)	60	65	60	75	
Failure Rate $\lambda_g$	0.023	0.040	0.035	0.075	

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For more detailed predictions the Connector Prediction model provided in MIL-HDBK-217F/Notice 2 Section 6.1 is used. The failure rate for a varistor is modeled by equation 3:

$$\lambda_{p} = \lambda_{b} \, \pi_{T} \, \pi_{S} \, \pi_{C} \, \pi_{Q} \, \pi_{E} \tag{3}$$

Where  $\lambda_p$ =is the predicted failure rate,  $\lambda_b$  is the base failure rate in failures per  $10^6$  hours,  $\pi_T$  is the temperature factor  $\pi_S$  is the voltage stress factor,  $\pi_C$  is the contact construction factor,  $\pi_C$  is the environmental factor.

Table 6 shows the failure rate prediction of a single suppression component with typical factors.

Table 6. Predicted Failure Rate of a Suppression Component

Single Connector	λ <sub>b</sub>	$\pi_T$	πs	π <sub>C</sub>	πο	πΕ	λp
Low Mating and Medium Temperature and Ground	0.0013	2.2	.19	1	2.4	6	0.00782496
Fixed	Base FR	50°C	<50%	Metal	JAN	G <sub>F</sub>	
Low Mating and Temperature and Ground Mobile	0.0013	1.2	.19	1	2.4	9	0.00640224
	Base FR	30°C	<50%	Metal	JAN	$G_{M}$	
High Mating, Medium Temp. and Ground Mobile	0.0013	2.2	.19	1	2.4	9	0.01173744
	Base FR	50°C	<50%	Metal	JAN	G <sub>M</sub>	
Moderate Mating and Temp and Naval Surface	0.0013	2.2	.19	1	2.4	9	0.01170744
	Base FR	50°C	<50%	Metal	JAN	Ns	0.01173744
Moderate Mating, High Temp and Aircraft Inhabited	0.0013	3.9	.19	1	2.4	13	0.03005496
	Base FR	70°C	<50%	Metal	JAN	A <sub>IC</sub>	